

## General-purpose single bipolar timers

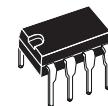
### Features

- Low turn-off time
- Maximum operating frequency greater than 500 kHz
- Timing from microseconds to hours
- Operates in both astable and monostable modes
- Output can source or sink up to 200 mA
- Adjustable duty cycle
- TTL compatible
- Temperature stability of 0.005% per °C

### Description

The NE555 monolithic timing circuit is a highly stable controller capable of producing accurate time delays or oscillation. In the time delay mode of operation, the time is precisely controlled by one external resistor and capacitor. For a stable operation as an oscillator, the free running frequency and the duty cycle are both accurately controlled with two external resistors and one capacitor.

The circuit may be triggered and reset on falling waveforms, and the output structure can source or sink up to 200 mA.

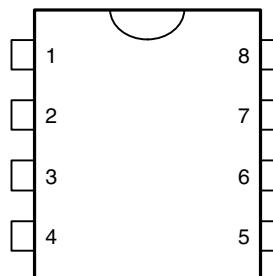


**N**  
**DIP8**  
(Plastic package)



**D**  
**SO8**  
(Plastic micropackage)

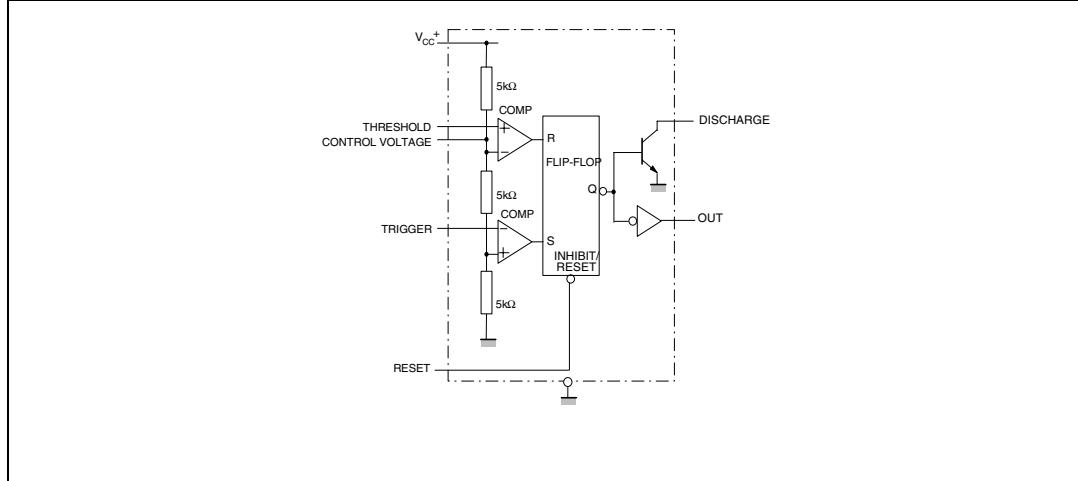
#### Pin connections (top view)



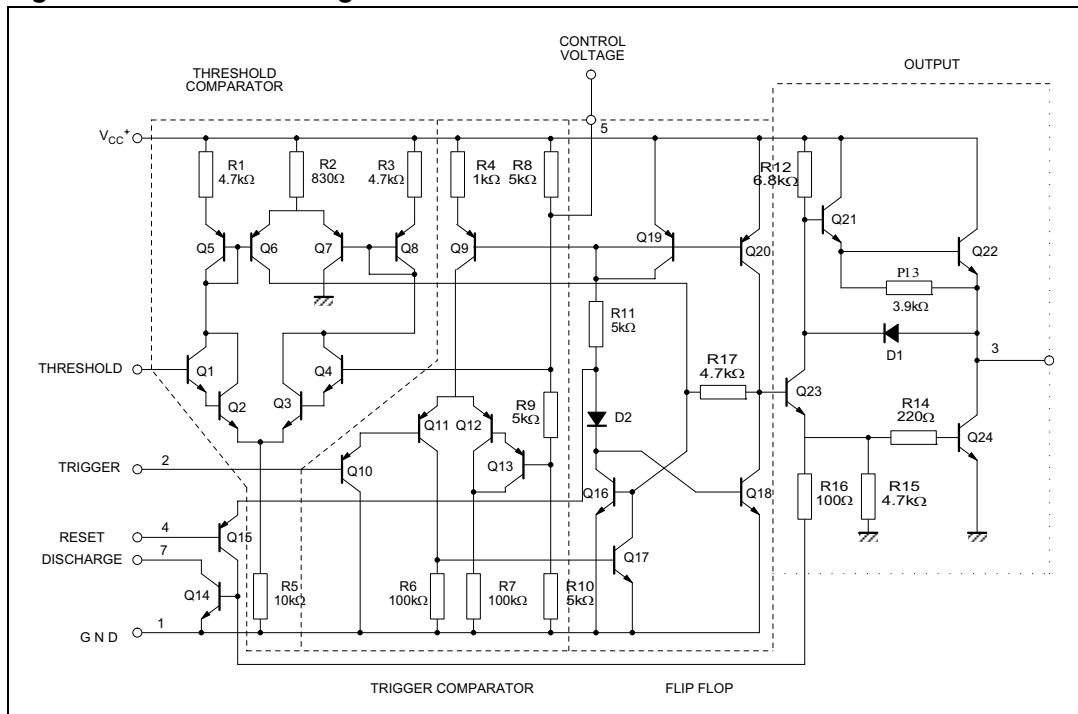
- |             |                     |
|-------------|---------------------|
| 1 - GND     | 5 - Control voltage |
| 2 - Trigger | 6 - Threshold       |
| 3 - Output  | 7 - Discharge       |
| 4 - Reset   | 8 - V <sub>CC</sub> |

# 1 Schematic diagrams

**Figure 1. Block diagram**



**Figure 2. Schematic diagram**



## 2 Absolute maximum ratings and operating conditions

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{CC}$	Supply voltage	18	V
$I_{OUT}$	Output current (sink & source)	$\pm 225$	mA
$R_{thja}$	Thermal resistance junction to ambient <sup>(1)</sup> DIP8 SO-8	85 125	°C/W
$R_{thjc}$	Thermal resistance junction to case <sup>(1)</sup> DIP8 SO-8	41 40	°C/W
ESD	Human body model (HBM) <sup>(2)</sup>	1000	V
	Machine model (MM) <sup>(3)</sup>	100	
	Charged device model (CDM) <sup>(4)</sup>	1500	
	Latch-up immunity	200	mA
$T_{LEAD}$	Lead temperature (soldering 10 seconds)	260	°C
$T_j$	Junction temperature	150	°C
$T_{stg}$	Storage temperature range	-65 to 150	°C

- Short-circuits can cause excessive heating. These values are typical.
- Human body model: a 100 pF capacitor is charged to the specified voltage, then discharged through a 1.5kΩ resistor between two pins of the device. This is done for all couples of connected pin combinations while the other pins are floating.
- Machine model: a 200 pF capacitor is charged to the specified voltage, then discharged directly between two pins of the device with no external series resistor (internal resistor < 5 Ω). This is done for all couples of connected pin combinations while the other pins are floating.
- Charged device model: all pins and the package are charged together to the specified voltage and then discharged directly to the ground through only one pin. This is done for all pins.

**Table 2. Operating conditions**

Symbol	Parameter	Value	Unit
$V_{CC}$	Supply voltage NE555 SA555 SE555	4.5 to 16 4.5 to 16 4.5 to 18	V
$V_{th}, V_{trig}, V_{cl}, V_{reset}$	Maximum input voltage	$V_{CC}$	V
$I_{OUT}$	Output current (sink and source)	$\pm 200$	mA
$T_{oper}$	Operating free air temperature range NE555 SA555 SE555	0 to 70 -40 to 105 -55 to 125	°C

### 3 Electrical characteristics

**Table 3.**  $T_{amb} = +25^\circ C$ ,  $V_{CC} = +5 V$  to  $+15 V$  (unless otherwise specified)

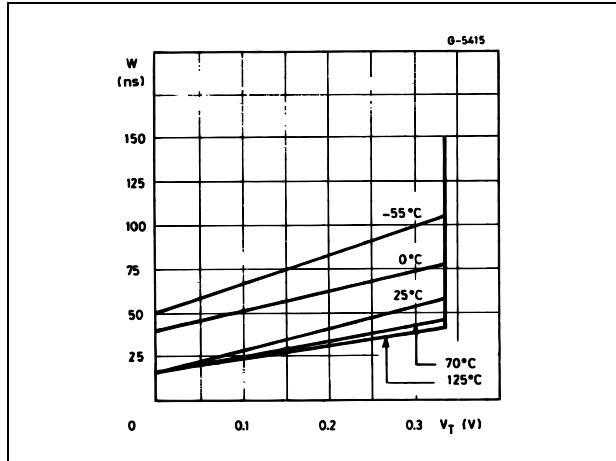
Symbol	Parameter	SE555			NE555 - SA555			Unit
		Min.	Typ.	Max.	Min.	Typ.	Max.	
$I_{CC}$	Supply current ( $R_L = \infty$ ) Low state $V_{CC} = +5V$ $V_{CC} = +15V$ High state $V_{CC} = +5V$		3 10 2	5 12		3 10 2	6 15	mA
	Timing error (monostable) ( $R_A = 2k\Omega$ to $100k\Omega$ , $C = 0.1\mu F$ ) Initial accuracy <sup>(1)</sup> Drift with temperature Drift with supply voltage		0.5 30 0.05	2 100 0.2		1 50 0.1	3 0.5	% ppm/ $^\circ C$ %/V
	Timing error (astable) ( $R_A, R_B = 1k\Omega$ to $100k\Omega$ , $C = 0.1\mu F$ , $V_{CC} = +15V$ ) Initial accuracy <sup>(1)</sup> Drift with temperature Drift with supply voltage		1.5 90 0.15			2.25 150 0.3		% ppm/ $^\circ C$ %/V
$V_{CL}$	Control voltage level $V_{CC} = +15V$ $V_{CC} = +5V$	9.6 2.9	10 3.33	10.4 3.8	9 2.6	10 3.33	11 4	V
$V_{th}$	Threshold voltage $V_{CC} = +15V$ $V_{CC} = +5V$	9.4 2.7	10 3.33	10.6 4	8.8 2.4	10 3.33	11.2 4.2	V
$I_{th}$	Threshold current <sup>(2)</sup>		0.1	0.25		0.1	0.25	$\mu A$
$V_{trig}$	Trigger voltage $V_{CC} = +15V$ $V_{CC} = +5V$	4.8 1.45	5 1.67	5.2 1.9	4.5 1.1	5 1.67	5.6 2.2	V
$I_{trig}$	Trigger current ( $V_{trig} = 0V$ )		0.5	0.9		0.5	2.0	$\mu A$
$V_{reset}$	Reset voltage <sup>(3)</sup>	0.4	0.7	1	0.4	0.7	1	V
$I_{reset}$	Reset current $V_{reset} = +0.4V$ $V_{reset} = 0V$		0.1 0.4	0.4 1		0.1 0.4	0.4 1.5	mA
$V_{OL}$	Low level output voltage $V_{CC} = +15V$ $I_{O(sink)} = 10mA$ $I_{O(sink)} = 50mA$ $I_{O(sink)} = 100mA$ $I_{O(sink)} = 200mA$ $V_{CC} = +5V$ $I_{O(sink)} = 8mA$ $I_{O(sink)} = 5mA$		0.1 0.4 2 2.5 0.1 0.05	0.15 0.5 2.2 2.5 0.25 0.2		0.1 0.4 2 2.5 0.3 0.25	0.25 0.75 2.5 0.4 0.35	V
$V_{OH}$	High level output voltage $V_{CC} = +15V$ $I_{O(sink)} = 200mA$ $I_{O(sink)} = 100mA$ $V_{CC} = +5V$ $I_{O(sink)} = 100mA$	13 3	12.5 13.3 3.3		12.75 2.75 3.3	12.5 13.3		V

**Table 3.**  $T_{amb} = +25^\circ C$ ,  $V_{CC} = +5 V$  to  $+15 V$  (unless otherwise specified) (continued)

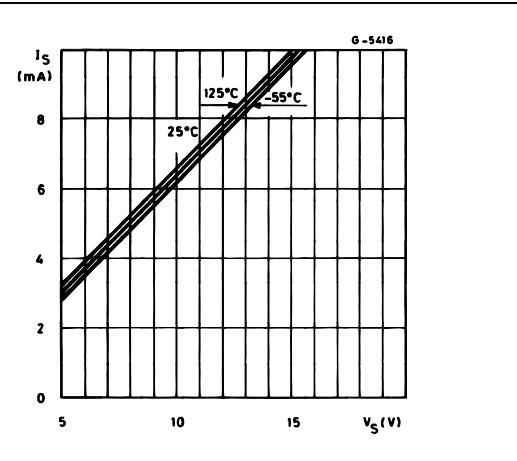
Symbol	Parameter	SE555			NE555 - SA555			Unit
		Min.	Typ.	Max.	Min.	Typ.	Max.	
$I_{dis(off)}$	Discharge pin leakage current (output high) $V_{dis} = 10V$		20	100		20	100	nA
$V_{dis(sat)}$	Discharge pin saturation voltage (output low) <sup>(4)</sup> $V_{CC} = +15V, I_{dis} = 15mA$ $V_{CC} = +5V, I_{dis} = 4.5mA$		180 80	480 200		180 80	480 200	mV
$t_r$ $t_f$	Output rise time Output fall time		100 100	200 200		100 100	300 300	ns
$t_{off}$	Turn off time <sup>(5)</sup> ( $V_{reset} = V_{CC}$ )		0.5			0.5		μs

1. Tested at  $V_{CC} = +5 V$  and  $V_{CC} = +15 V$ .
2. This will determine the maximum value of  $R_A + R_B$  for 15 V operation. The maximum total ( $R_A + R_B$ ) is 20 MΩ for +15 V operation and 3.5 MΩ for +5 V operation.
3. Specified with trigger input high.
4. No protection against excessive pin 7 current is necessary, providing the package dissipation rating is not exceeded.
5. Time measured from a positive pulse (from 0 V to  $0.8 \times V_{CC}$ ) on the Threshold pin to the transition from high to low on the output pin. Trigger is tied to threshold.

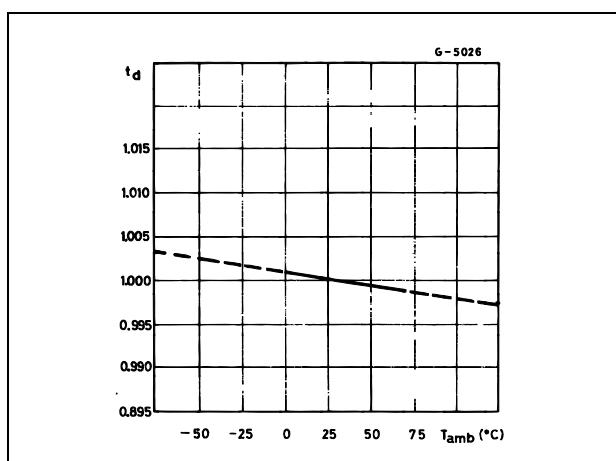
**Figure 3.** Minimum pulse width required for triggering



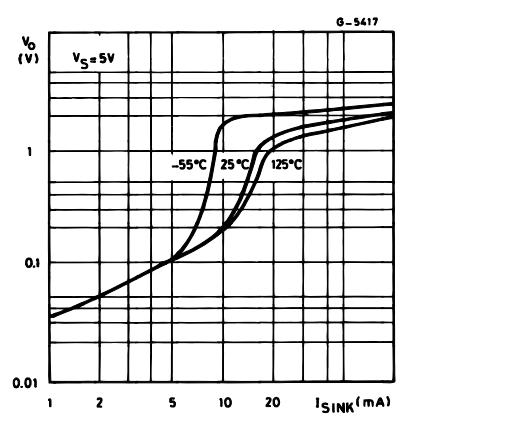
**Figure 4.** Supply current versus supply voltage



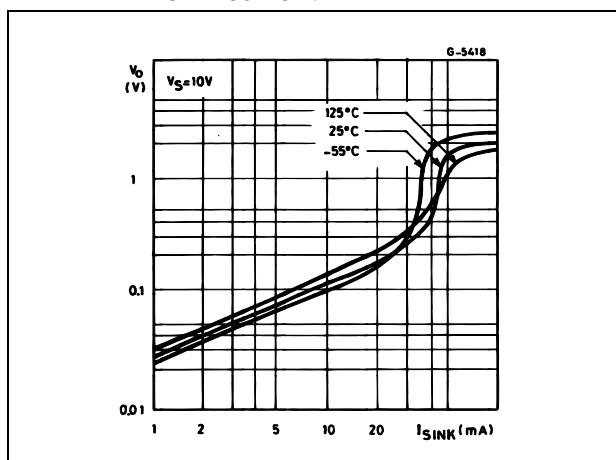
**Figure 5.** Delay time versus temperature



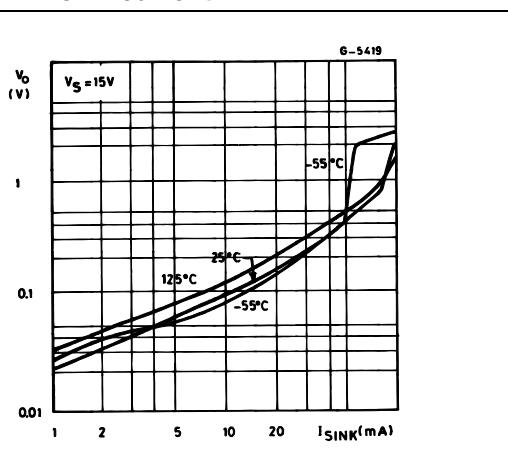
**Figure 6.** Low output voltage versus output sink current



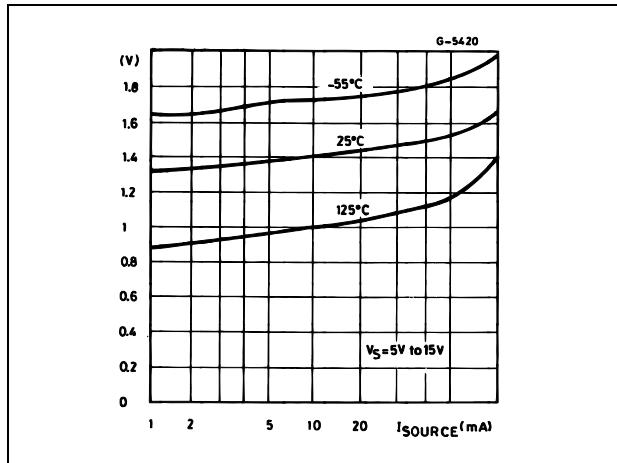
**Figure 7.** Low output voltage versus output sink current



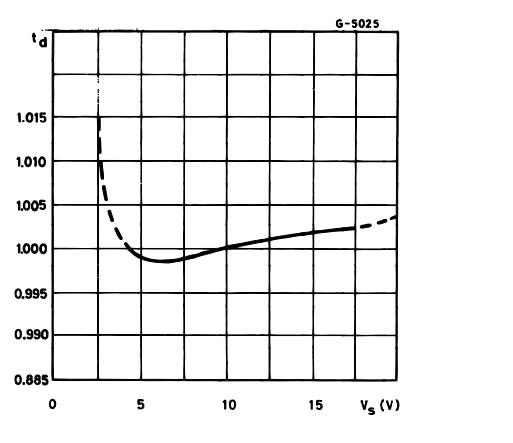
**Figure 8.** Low output voltage versus output sink current



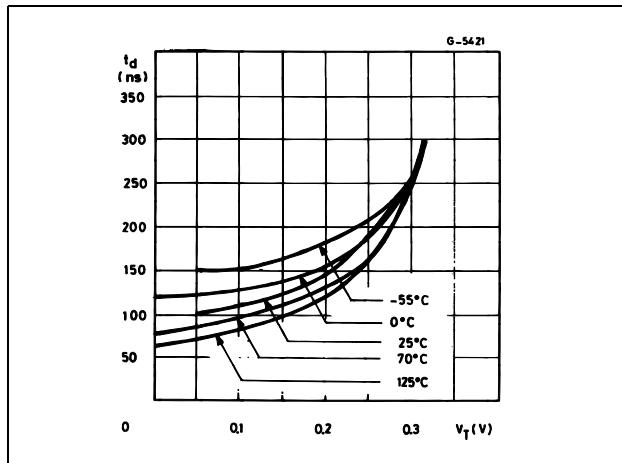
**Figure 9.** High output voltage drop versus output



**Figure 10.** Delay time versus supply voltage



**Figure 11.** Propagation delay versus voltage level of trigger value

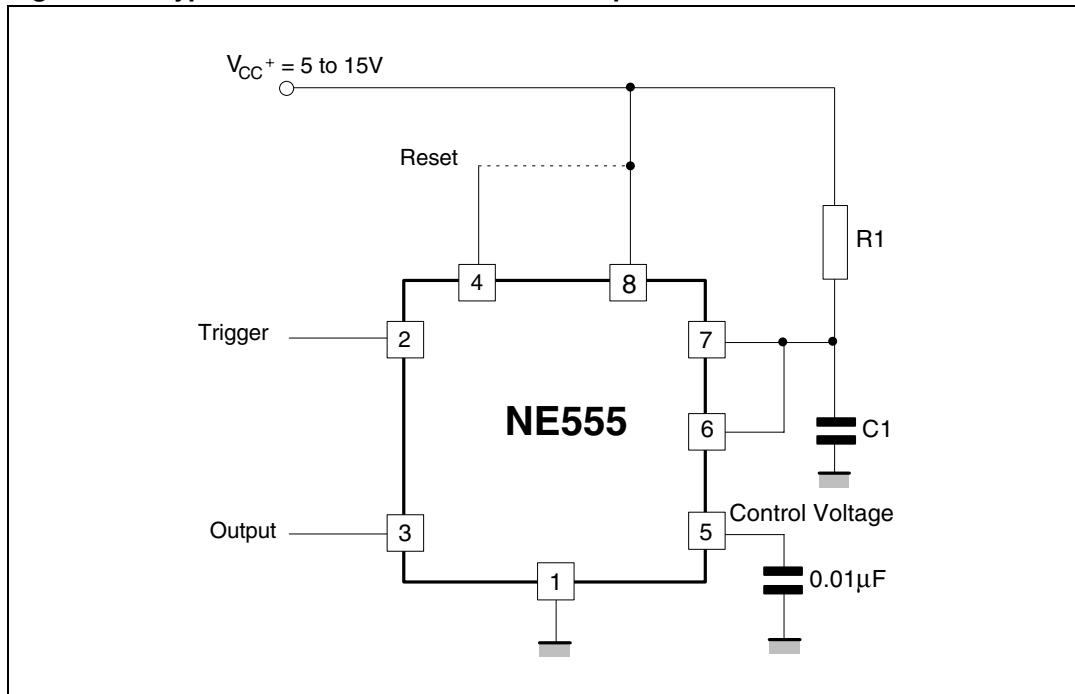


## 4 Application information

### 4.1 Monostable operation

In the monostable mode, the timer generates a single pulse. As shown in [Figure 12](#), the external capacitor is initially held discharged by a transistor inside the timer.

**Figure 12. Typical schematics in monostable operation**



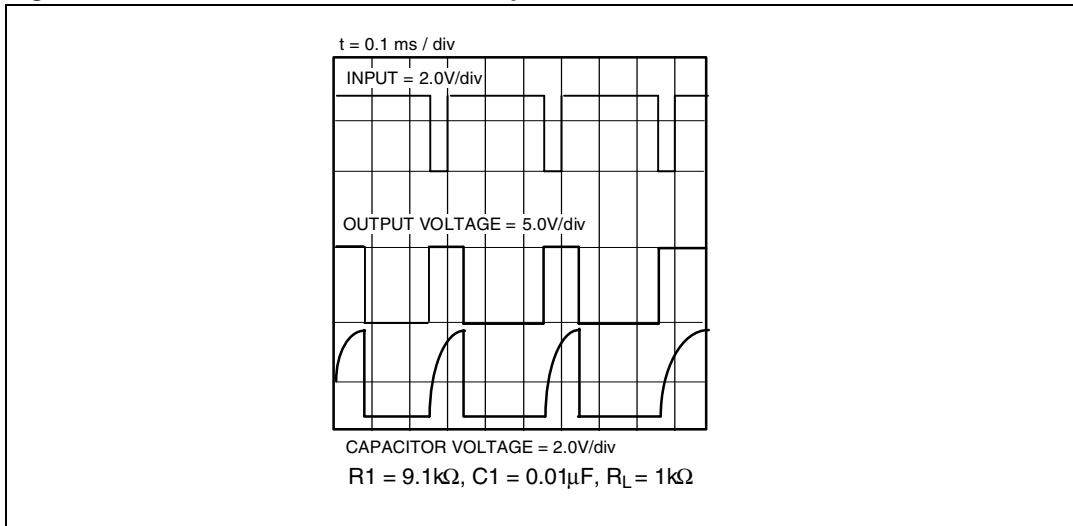
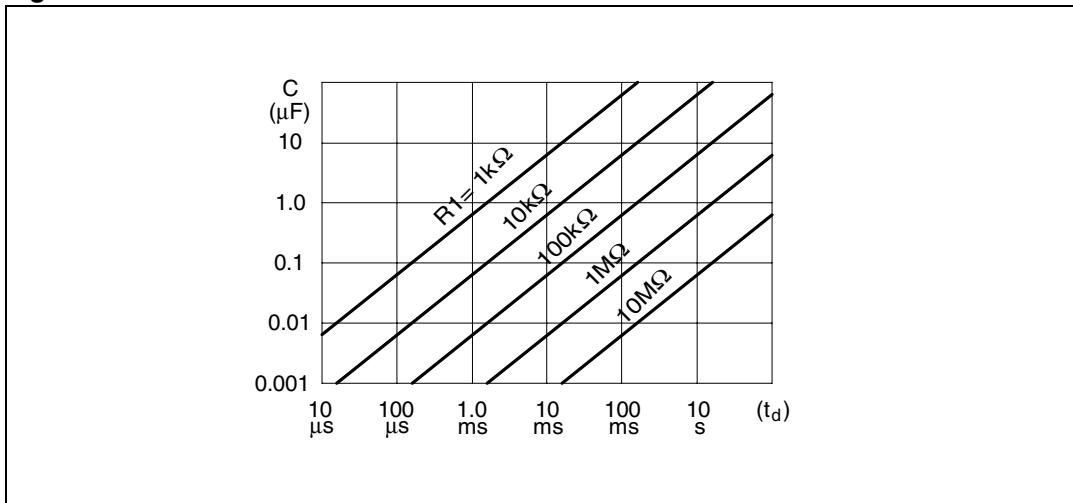
The circuit triggers on a negative-going input signal when the level reaches  $1/3 V_{CC}$ . Once triggered, the circuit remains in this state until the set time has elapsed, even if it is triggered again during this interval. The duration of the output HIGH state is given by  $t = 1.1 R_1 C_1$  and is easily determined by [Figure 14](#).

Note that because the charge rate and the threshold level of the comparator are both directly proportional to supply voltage, the timing interval is independent of supply. Applying a negative pulse simultaneously to the reset terminal (pin 4) and the trigger terminal (pin 2) during the timing cycle discharges the external capacitor and causes the cycle to start over. The timing cycle now starts on the positive edge of the reset pulse. During the time the reset pulse is applied, the output is driven to its LOW state.

When a negative trigger pulse is applied to pin 2, the flip-flop is set, releasing the short-circuit across the external capacitor and driving the output HIGH. The voltage across the capacitor increases exponentially with the time constant  $t = R_1 C_1$ . When the voltage across the capacitor equals  $2/3 V_{CC}$ , the comparator resets the flip-flop which then discharges the capacitor rapidly and drives the output to its LOW state.

[Figure 13](#) shows the actual waveforms generated in this mode of operation.

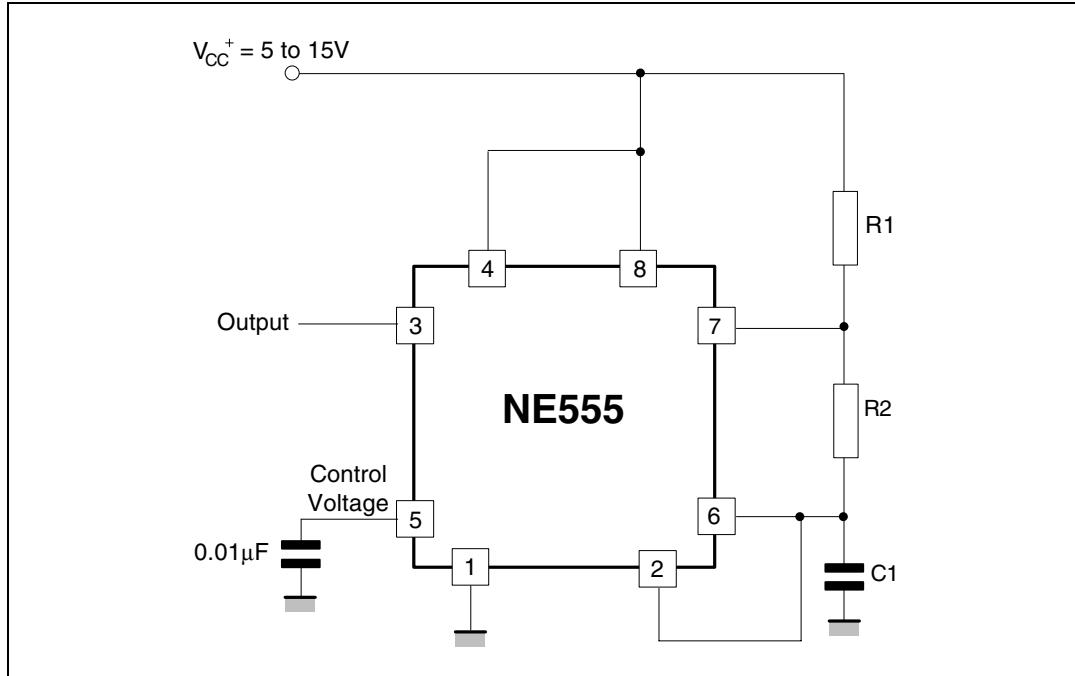
When Reset is not used, it should be tied high to avoid any possibility of unwanted triggering.

**Figure 13.** Waveforms in monostable operation**Figure 14.** Pulse duration versus R<sub>1</sub>C<sub>1</sub>

## 4.2 Astable operation

When the circuit is connected as shown in [Figure 15](#) (pins 2 and 6 connected) it triggers itself and free runs as a multi-vibrator. The external capacitor charges through R<sub>1</sub> and R<sub>2</sub> and discharges through R<sub>2</sub> only. Thus the duty cycle can be set accurately by adjusting the ratio of these two resistors.

In the astable mode of operation, C<sub>1</sub> charges and discharges between 1/3 V<sub>CC</sub> and 2/3 V<sub>CC</sub>. As in the triggered mode, the charge and discharge times and, therefore, frequency are independent of the supply voltage.

**Figure 15. Typical schematics in astable operation**

*Figure 16* shows the actual waveforms generated in this mode of operation.

The charge time (output HIGH) is given by:

$$t_1 = 0.693 (R_1 + R_2) C_1$$

and the discharge time (output LOW) by:

$$t_2 = 0.693 (R_2) C_1$$

Thus the total period  $T$  is given by:

$$T = t_1 + t_2 = 0.693 (R_1 + 2R_2) C_1$$

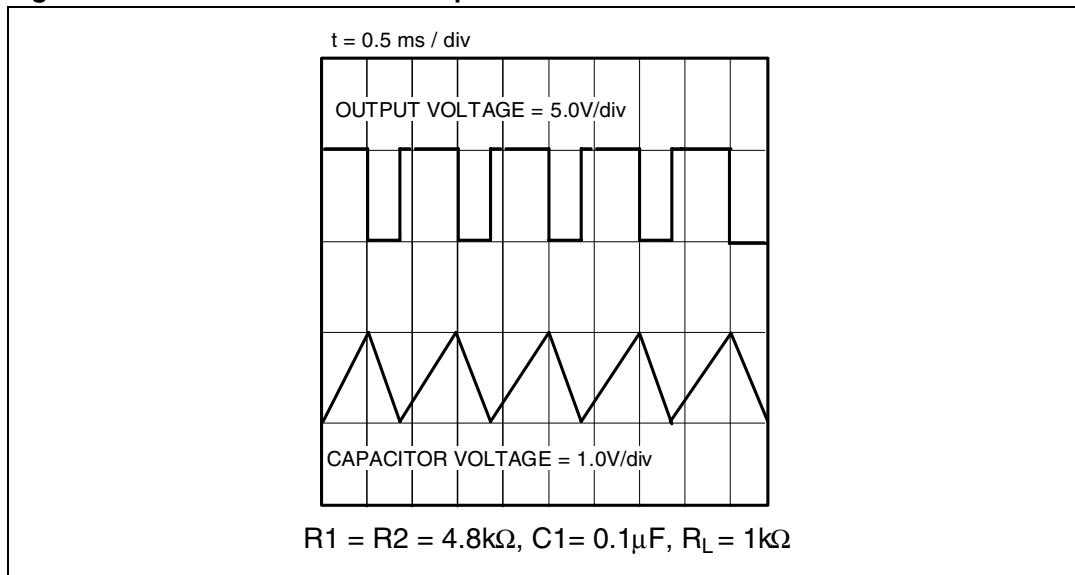
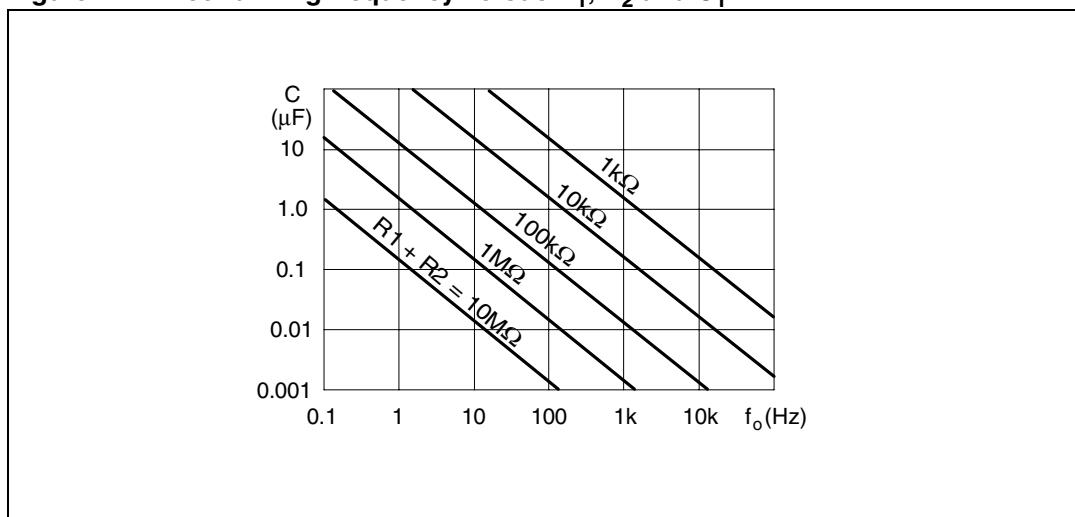
The frequency of oscillation is then:

$$f = \frac{1}{T} = \frac{1.44}{(R_1 + 2R_2)C_1}$$

It can easily be found from *Figure 17*.

The duty cycle is given by:

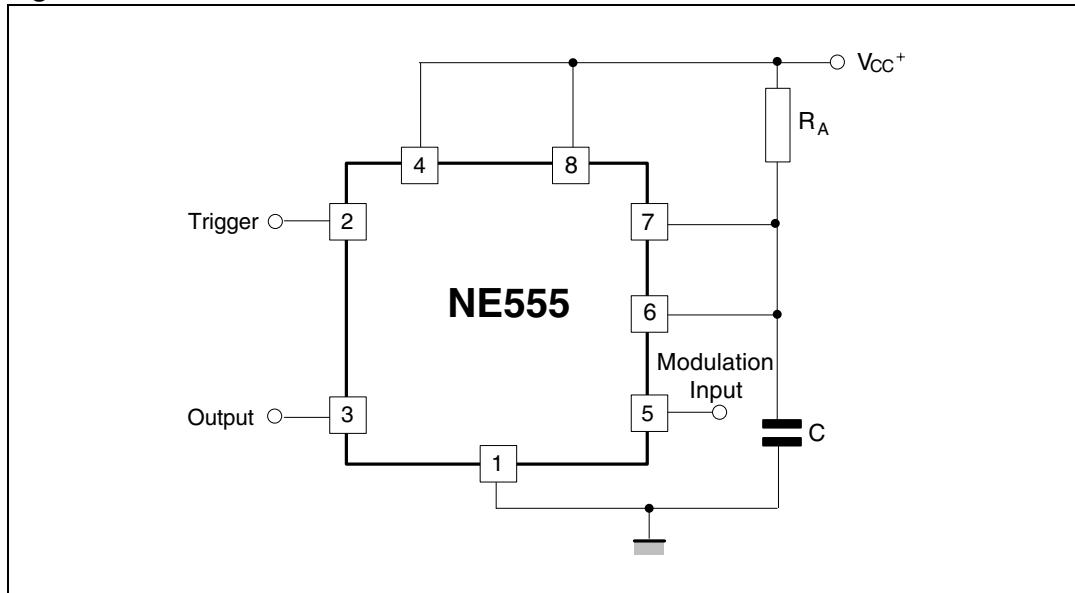
$$D = \frac{R_2}{R_1 + 2R_2}$$

**Figure 16. Waveforms in astable operation****Figure 17. Free running frequency versus R<sub>1</sub>, R<sub>2</sub> and C<sub>1</sub>**

### 4.3 Pulse width modulator

When the timer is connected in the monostable mode and triggered with a continuous pulse train, the output pulse width can be modulated by a signal applied to pin 5. [Figure 18](#) shows the circuit.

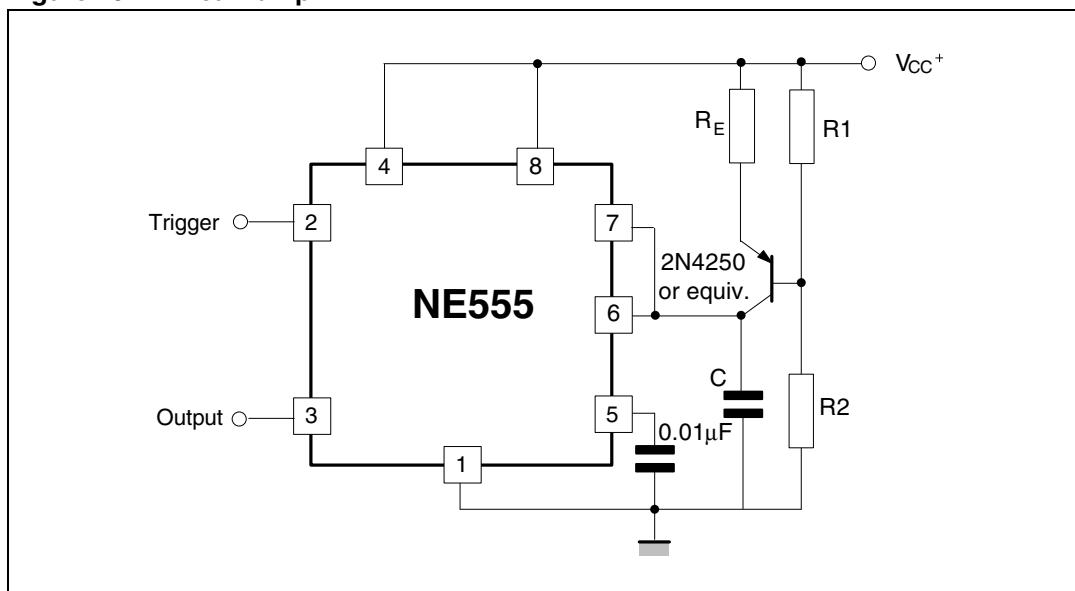
**Figure 18. Pulse width modulator**



### 4.4 Linear ramp

When the pull-up resistor, R<sub>A</sub>, in the monostable circuit is replaced by a constant current source, a linear ramp is generated. [Figure 19](#) shows a circuit configuration that will perform this function.

**Figure 19. Linear ramp**

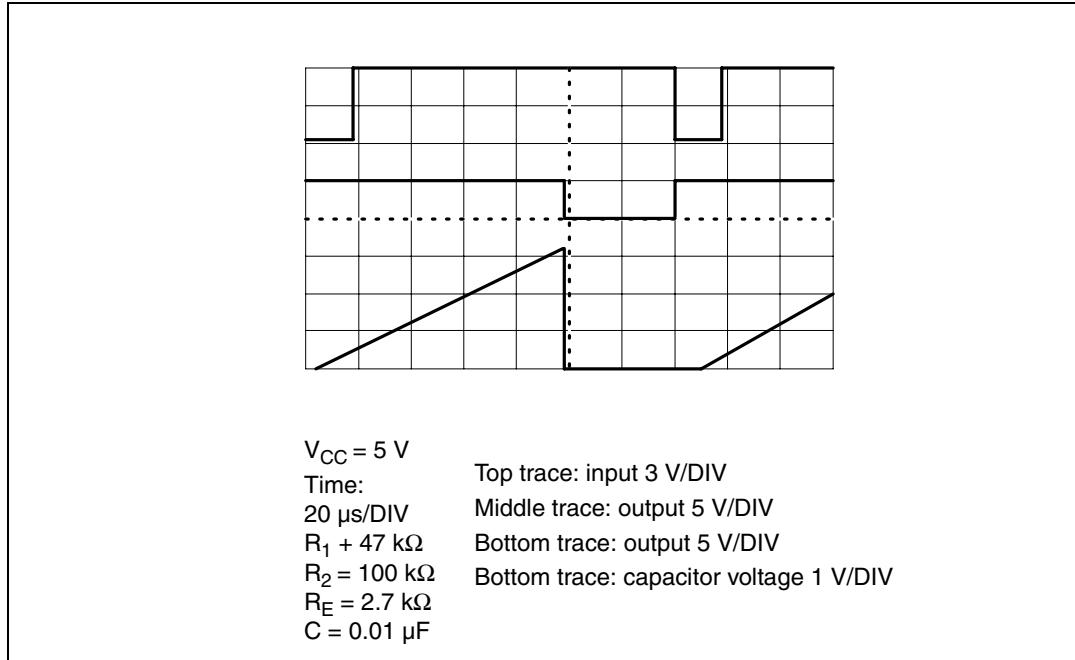


*Figure 20* shows the waveforms generator by the linear ramp.

The time interval is given by:

$$T = \frac{(2/3 V_{CC} R_E (R_1+R_2) C)}{R_1 V_{CC} - V_{BE} (R_1+R_2)} \quad V_{BE} = 0.6V$$

**Figure 20. Linear ramp**



## 4.5 50% duty cycle oscillator

For a 50% duty cycle, the resistors  $R_A$  and  $R_B$  can be connected as in *Figure 21*. The time period for the output high is the same as for astable operation (see *Section 4.2 on page 9*):

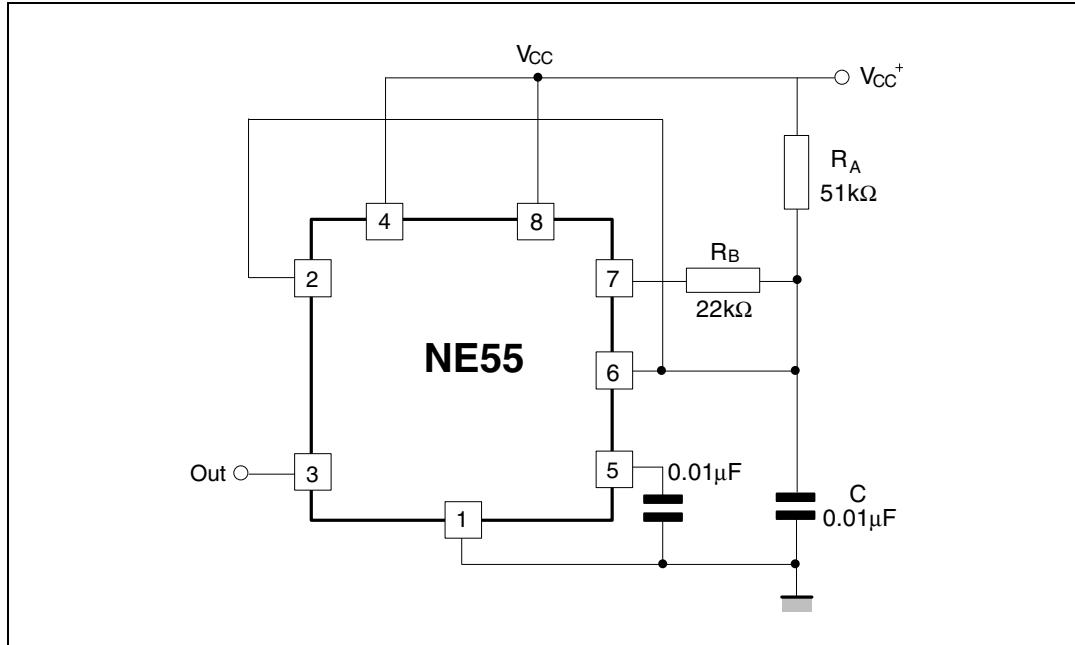
$$t_1 = 0.693 R_A C$$

For the output low it is

$$t_2 = [(R_A R_B)/(R_A + R_B)] C \ln \left[ \frac{RB - 2RA}{2RB - RA} \right]$$

Thus the frequency of oscillation is:

$$f = \frac{1}{t_1 + t_2}$$

**Figure 21.** 50% duty cycle oscillator

Note that this circuit will not oscillate if  $R_B$  is greater than  $1/2 R_A$  because the junction of  $R_A$  and  $R_B$  cannot bring pin 2 down to  $1/3 V_{CC}$  and trigger the lower comparator.

## 4.6 Additional information

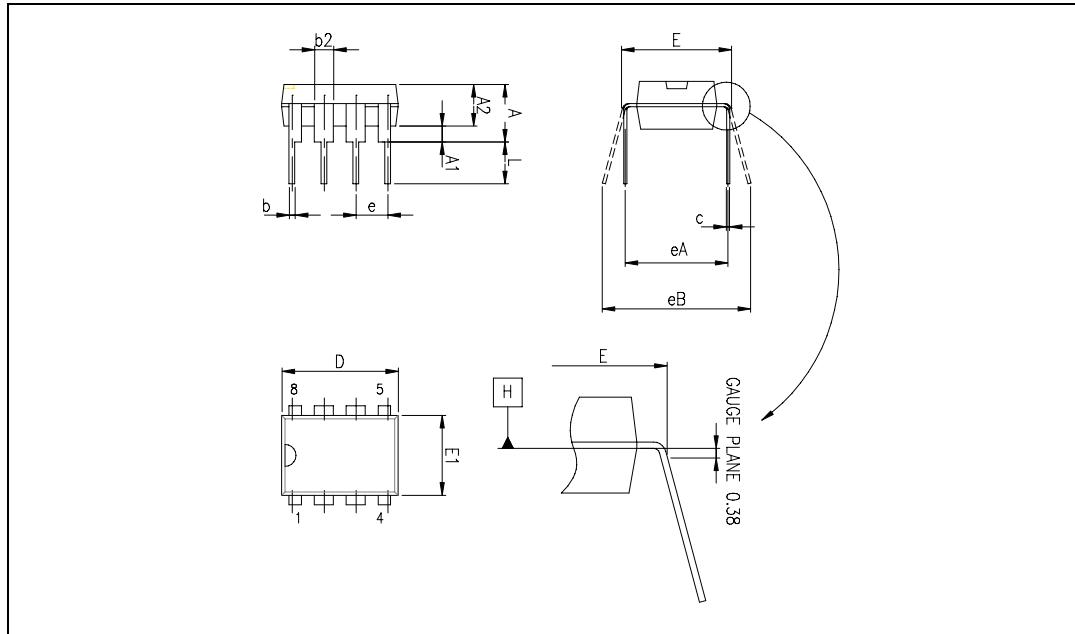
Adequate power supply bypassing is necessary to protect associated circuitry. The minimum recommended is  $0.1 \mu\text{F}$  in parallel with  $1 \mu\text{F}$  electrolytic.

## 5 Package information

In order to meet environmental requirements, STMicroelectronics offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an STMicroelectronics trademark. ECOPACK specifications are available at: [www.st.com](http://www.st.com).

## 5.1 DIP8 package information

**Figure 22.** DIP8 package mechanical drawing



**Table 4.** DIP8 package mechanical data

Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A			5.33			0.210
A1	0.38			0.015		
A2	2.92	3.30	4.95	0.115	0.130	0.195
b	0.36	0.46	0.56	0.014	0.018	0.022
b2	1.14	1.52	1.78	0.045	0.060	0.070
c	0.20	0.25	0.36	0.008	0.010	0.014
D	9.02	9.27	10.16	0.355	0.365	0.400
E	7.62	7.87	8.26	0.300	0.310	0.325
E1	6.10	6.35	7.11	0.240	0.250	0.280
e		2.54			0.100	
eA		7.62			0.300	
eB			10.92			0.430
L	2.92	3.30	3.81	0.115	0.130	0.150

## 5.2 SO-8 package information

Figure 23. SO-8 package mechanical drawing

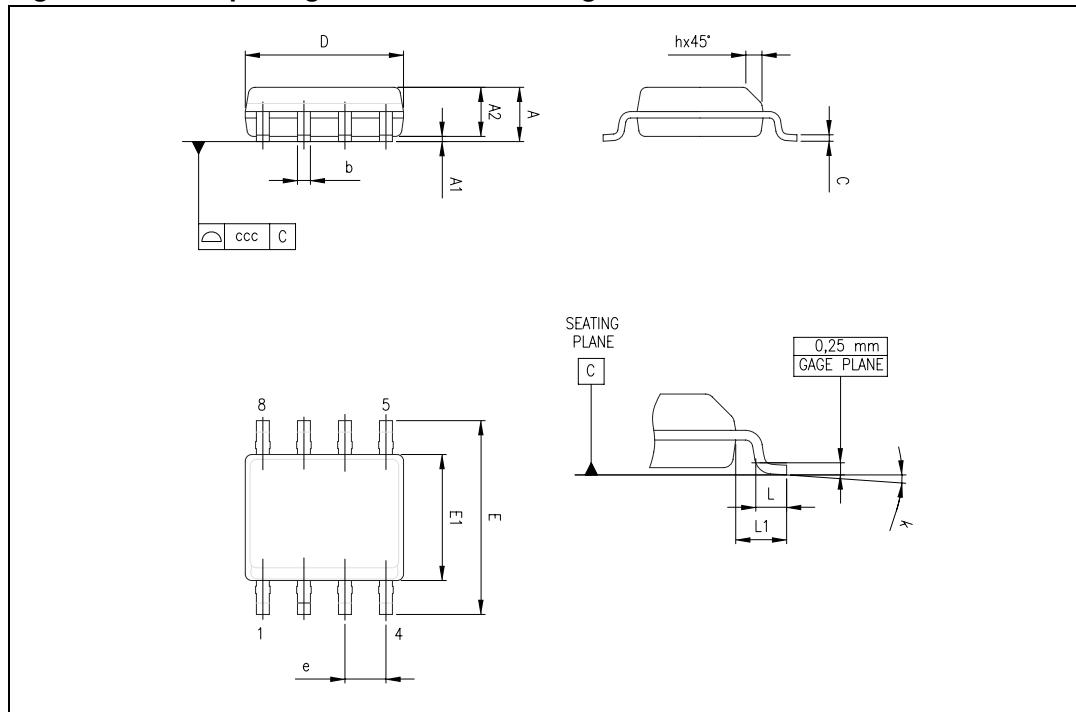


Table 5. SO-8 package mechanical data

Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A			1.75			0.069
A1	0.10		0.25	0.004		0.010
A2	1.25			0.049		
b	0.28		0.48	0.011		0.019
c	0.17		0.23	0.007		0.010
D	4.80	4.90	5.00	0.189	0.193	0.197
E	5.80	6.00	6.20	0.228	0.236	0.244
E1	3.80	3.90	4.00	0.150	0.154	0.157
e		1.27			0.050	
h	0.25		0.50	0.010		0.020
L	0.40		1.27	0.016		0.050
L1		1.04			0.040	
k	0		8°	1°		8°
ccc			0.10			0.004

## 6 Ordering information

**Table 6. Order codes**

Part number	Temperature range	Package	Packing	Marking
NE555N	0°C, +70°C	DIP8	Tube	NE555N
NE555D/DT		SO-8	Tube or tape & reel	NE555
SA555N	-40°C, +105°C	DIP8	Tube	SA555N
SA555D/DT		SO-8	Tube or tape & reel	SA555
SE555N	-55°C, + 125°C	DIP8	Tube	SE555N
SE555D/DT		SO-8	Tube or tape & reel	SE555

## 7 Revision history

**Table 7. Document revision history**

Date	Revision	Changes
01-Jun-2003	1	Initial release.
2004-2006	2-3	Internal revisions
15-Mar-2007	4	Expanded order code table. Template update.
06-Nov-2008	5	Added $I_{OUT}$ value in <i>Table 1: Absolute maximum ratings</i> and <i>Table 2: Operating conditions</i> . Added ESD tolerance, latch-up tolerance, $R_{thja}$ and $R_{thjcin}$ <i>Table 1: Absolute maximum ratings</i> .

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